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Analytical X-Ray Acquisition System Analog / Digital

Manual







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This manual covers the KETEK AXAS-A (s/n Axxxx) and AXAS-D (s/n Dxxxx) products only. For other products please refer to a corresponding document or contact us (chapter 9).

Revision history:

Rev. 1.6, March 2021: Declaration of conformity updated

Rev. 1.5, June 2020: VICO-DP manual updated to version 1.3 (minor changes)

Rev. 1.4, July 2018: power connector pin numbers revised matching the manufacturer's nomenclature (Binder)

Rev. 1.3, March 2018: technical drawings updated (RS232 connector)

Rev. 1.2, December 2017: VICO-DP manual updated to version 1.2

Rev. 1.1, August 2017: power connector pinning revised, section 2.22

Rev. 1.0, July 2017



Dear Customer,

Thank you for choosing the KETEK AXAS-A/D system. We ensure you that this product has been manufactured with highest industry standards in order to meet your quality expectations. Our highest priority is to deliver you the best product on the market.

1 Safety and Warranty

1.1 Cautions and Warnings

It is strongly recommended to read this user manual carefully and completely before installing or activating the SDD. Please keep this user manual always with the system to allow any operator access to this important information. In case of a potential resale or scrapping of the system at the end of its lifetime, this manual should be given along with the device.

Follow the cautions and warnings listed below to avoid injuries and warranty loss.



WARNING

Your detector contains a very small amount of toxic beryllium as window material. If this window is broken, do not inhale the beryllium particles and follow our safety instructions in chapter 7.



The thin Beryllium window is very brittle and can shatter easily in case of mechanical stress. If the window is damaged, the vacuum encapsulation is no longer given and the SDD cannot be operated properly anymore. The plastic protection cap that covers the Be window carries a sticker with a toxicity warning.



Never touch the Be window surface!



Never try to clean the Be window surface!



Prevent any gas or particle stream from the SDD window!



A damaged entrance window may implode and scatter small beryllium particles in the immediate vicinity of the SDD. In this case, rigorously clean the SDD and its surrounding area. Follow all the precautions specified in section 7.

Since repair of an SDD with a damaged Be window is not possible, the detector module has to be replaced by a new one.



A Beryllium window damage due to improper handling is not covered by KETEK's product warranty.



Scrapping of an SDD at end of its lifetime has to be done according to the country-specific legal regulations.





Do not dispose the SDD together with your domestic waste in any case. Alternatively you can return the damaged detector for disposal at KETEK free of charge.



For safety reasons, always keep the white SDD protection cap with the system. This also applies for fixed installations. The cap must be mounted during cleaning of the housing, service or shipping in order to protect the beryllium window.



Make sure the specimens under test will never touch the SDD window.



Repair or maintenance of the detection unit must be performed by KETEK only. Any violation leads to the loss of the product warranty.



To prevent an electrical shock, do not open the housing and do not touch the SDD.



Do not drop or cause mechanical shock to the detector. Components inside the detector are mechanically fragile and may be damaged if the unit is dropped.



WARNING

High voltages need to be applied to the detector for use. To prevent electrical shock, do not touch the detector and any electrical contacts. Do not remove the covers.



Avoid temperature and air pressure shocks. Make sure to acclimate the system slowly. Especially in evacuated applications, be sure to ventilate slowly.



Radiation damage to the detector will occur if it is exposed to a high flux environment. Synchrotron Radiation Beams should be modified with attenuators before they are allowed to strike the detector or the fluorescence target. Damage to the detector will be permanent if the flux from an X-ray tube, a strong nuclear radiation source, or an accelerator is not attenuated.



Keep the device dry and clean!

1.2 Warranty

KETEK GmbH warrants to the original purchaser this instrument to be free from defects in materials and workmanship for a period of one year from shipment. KETEK GmbH will, without charge, repair or replace (at its option) a defective instrument upon return to the factory. This warranty does not apply in the event of misuse or abuse of the instrument or unauthorized alterations or repair. KETEK GmbH shall not be liable for any consequential damages, including without limitation, damages resulting from the loss of use due to failure of this instrument. All products returned under the warranty must be shipped prepaid to the factory with documentation describing the problem and the circumstances under which it was observed. Additionally the statement of contamination must be filled out completely and returned with the product. KETEK must be notified prior to return shipment. The instrument will be evaluated, repaired or replaced, and promptly returned if the warranty claims are substantiated. A nominal fee will be charged for unsubstantiated claims. Please include the model and serial number in all correspondence with KETEK

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2 Product Description

The AXAS-A/D is an analytical X-ray acquisition system encapsulated in a single housing. There are two versions of this product:

AXAS-A: the analog version of the system, only the analog signal is available.

AXAS-D: the digital version of the system with an integrated digital pulse processor (VICO-DP). The output signal is a digitized spectrum. However the analog signal output is also available and can be used simultaneously with the digital one.

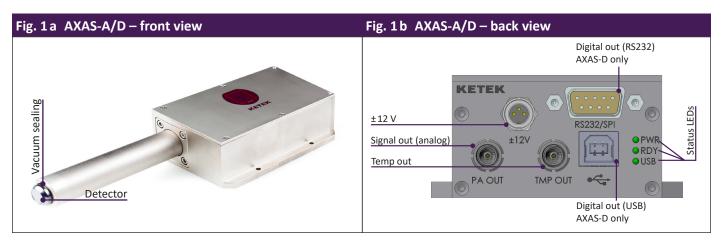
2.1 Features

- Highly integrated design with all power options
- All VITUS SDD types (FET and CUBE) from 7 mm to 50 mm² available
- KETEK reset-type pre-amplifier
- Low-noise power supplies for SDD and TEC
- SDD operating temperature read-out
- Finger lengths from 50 to 200 mm
- Vacuum compatible
- High-speed USB 2.0 and RS-232 interfaces (AXAS-D only).

The AXAS-A/D contains all necessary electronics needed for an operation of a SDD. The main components are:

- SDD preamplifier for either FET or CUBE based detectors
- High voltage driver for the a drift field generation (please refer to chapter 8 for details)
- TEC temperature controller for the Peltier cooling element inside the SDD
- Digital pulse processor (AXAS-D only) for signal processing and spectra generation

All components are mounted within a single housing which is shown in Fig. 1a and Fig. 1b.



The AXAS-A/D is equipped with three status LEDs.

- **PWR** lights up as soon as the unit is turned on. The SDD starts cooling down.
- RDY indicates that the proper temperature has been reached and the system is ready for operation.
- USB signifies the connection to the PC (AXAS-D only).

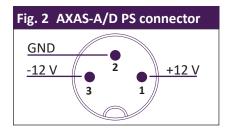


2.2 Power connector

This unit must be supplied with \pm 12 V DC (see Tab. 2 and Tab. 3 for details). It is recommended to use the KETEK APS-L power supply in order to achieve the best voltage stability and system performance.

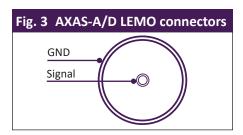
For connecting a custom power supply use the **BINDER 3-pole (99-0076-100-03)** connector. The Fig. 2 shows the power connector located on the AXAS-A/D with the corresponding +/-12 V DC voltage lines.

Please be sure that the mating connector is correctly wired before turning on the device.



2.3 Analog signal and temperature output connectors

Please use for both, analog signal and chip temperature read out, the **LEMO FFS.00.250** connectors according to the Tab. 1.



Tab. 1 AXAS-A/D signal and temp. connectors		
Description	Typical value	
Signal output (PA out)	Load resistance $\geq 50 \Omega$	
Temp. output (TMP out)	Load resistance $\geq 1 \text{ M}\Omega$	

AXAS-A/D User's manual Page 4



3 Specification

3.1 Electrical parameters

Tab.	Tab. 2 AXAS-A electrical parameters				
	Parameter	Typ. rating*	Max. rating**		
ve	DC voltage	+12 V ± 5 %	+10.8 V to +13 V		
Positive	Current	200 mA @ -35 °C chip temp.			
PC	Dissipation loss	2.4 W	9.75 W		
ive	DC voltage	-12 V ± 5 %	- 10.8 V to - 13 V		
Negative	Current	30 mA			
S	Dissipation loss	0.36 W	4.875 W		

Tab.	Tab. 3 AXAS-D electrical parameters				
	Parameter	Typ. rating*	Max. rating		
ve	DC voltage	+12 V ± 5 %	+10.8 V to +13 V		
Positive	Current	370 mA @ -35 °C chip temp.			
PC	Dissipation loss	4.5 W	9.75 W		
ive	DC voltage	-12 V ± 5 %	- 10.8 V to - 13 V		
Negative	Current	50 mA			
Ne	Dissipation loss	0.6 W	4.875 W		

^{*} Measured at +20 °C heat sink temp. of AXAS, -35 °C SDD chip temp., steady state

Tab.	Tab. 4 AXAS-A/D absolute maximum ratings		
	Parameter	Max. rating**	
Pos.	DC voltage	+13 V	
Po	Current	750 mA fused	
Neg.	DC voltage	-13 V	
Ž	Current	375 mA fused	

^{**}Stresses beyond those listed ratings may cause permanent damage to the device. This is a stress rating only; functional operation of the device at other than recommended conditions is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.

Max. rating values reached for few seconds after powering on or full thermal load, PPPM 1500 W (Peak pulse current with a 10/1000 μ s waveform, IFSM 200 A (Peak forward surge current 8.3 ms single half sine-wave).



3.2 Ambient conditions

Tab. 5 AXAS-A/D allowed ambient conditions				
	Parameter	Min.	Max.	Note
	Temperature	0 °C	+50 °C	
Operate	Humidity	10 % RH	80 % RH	
Эре	Pressure	0 atm	1.1 atm	Non condensing
	Pressure change		100 mbar/s	environment
Store	Temperature	0 °C	+50 °C	
Stc	Humidity	10 % RH	90 % RH	

3.3 Signal parameters

Tab.	Tab. 6 AXAS-A/D signal parameters		
	Parameter	Specification	
ಹ	Signal form	Ramped reset type	
Analog	Signal range	+1 V to -2 V	
⋖	Gain factor	5 mV/keV	
	Peaking time range	0.1 to 24 μs in 24 steps	
S-D	No. of channels	max. 8192	
ΑΧΑ	Channel depth	24 bit	
al (,	ADC	14 bit	
Oigital (AXAS-D)	Max. read out speed	1.7 ms (@1024 channels)	
	Clock frequency	40 MHz	

3.4 General parameters

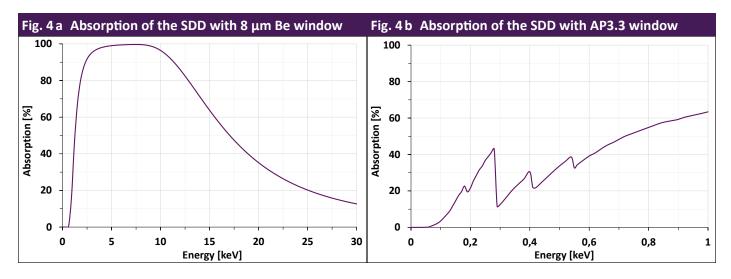
Tab. 7 AXAS-A/D general parameters			
Parameter	Specification		
Vacuum tightness	Optional; He leakage rate < 10 ⁻⁹ mbar·l/s		
Temperature monitor	Thermistor		
Radiation hardness @ 17 keV	≤ 10 ¹² photons		
Weight (100 mm Al finger)	690 g (AXAS-A), 710 g (AXAS-D)		
Digital interface (AXAS-D)	USB 2.0 or RS-232 @ 921 kBaud		

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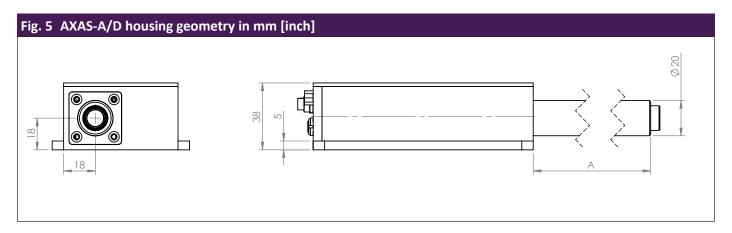


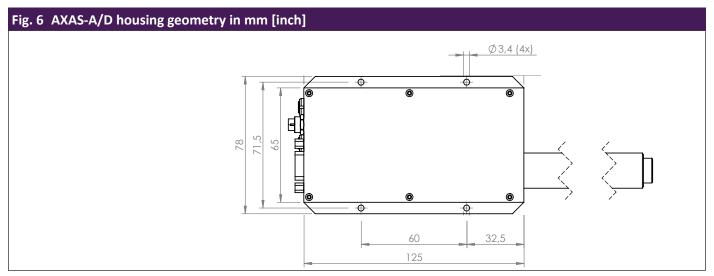
3.5 SDD absorption

The X-ray radiation absorption capability of the AXAS-A/D depends on the mounted SDD only. The absorption curves for the 8 μ m Beryllium and the AP3.3 windows are shown below.



3.6 Dimensions







4 Getting started

Remove the AXAS-A/D system carefully from the transport case.

Leave the white protection cap on the SDD in order to avoid window damage during the handling.



i WARNING

Be very careful if the beryllium window has been damaged. Do not inhale the beryllium particles and proceed as described in chapter 7.



IMPORTANT

Make sure that all necessary requirements for meeting the ESD cautions are fulfilled.

- Mount the AXAS-A/D in your measurement equipment at a desired position. Please notice that only the finger of the AXAS-A/D unit can be operated under vacuum conditions. Therefore be sure that the housing of the AXAS-A/D unit with the optional APS-L power supply are operated under atmospheric pressure.
- 2. Connect a power supply to AXAS-A/D. Please be sure in case you are not using the KETEK APS-L power supply that your connector is properly wired.
- Check the supply voltages (in case of a custom power supply) if the maximum values are not exceeded as stated in Tab. 2 and Tab. 3 on page 5.
- Connect a signal input of your signal processing device to the signal output of the AXAS-A/D. 4. In case of the AXAS-D this is optional.
- Connect the AXAS-D to a host PC using a USB or RS-232 interface (not applicable for AXAS-A) 5.
- 6. Remove the SDD protection cap very slowly and carefully.

Do not touch the SDD with your fingers or with the protection cap.

Please ensure that the specimen can not contact the SDD at any time, as this may cause a Beryllium window damage which is not covered by warranty.

- 7. Turn on the power supply. Make sure that the PWR LED indication is on.
- 8. Wait until the RDY LED indication lights up.

Your AXAS-A/D system is ready for operation

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5 Operating AXAS-A/D

The PWR and RDY LED indications show that the AXAS-A/D system is ready and the SDD has reached its operating temperature. In this state the SDD is already working and the output signal is being generated.

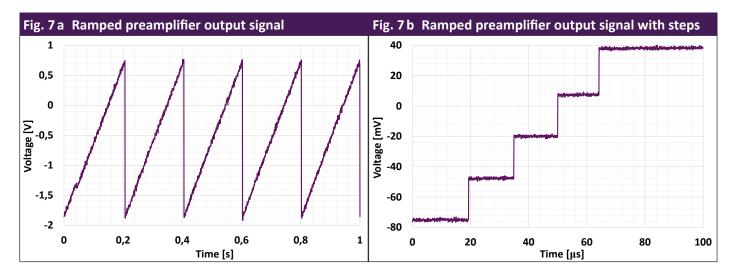
Additionally in case you are using the AXAS-D and you have connected it to a PC the USB LED would light up.

5.1 Analog output signal

The typical output signal is a ramp as shown in Fig. 7a. If the SDD is exposed to X-ray radiation, the ramp signal is shorter with some low amplitude steps as shown in Fig. 7b. Every single step on the ramp signal corresponds to a photon which has been absorbed in the SDD. By measuring the hight of this step the energy of this photon can be determined.

The ramped signal is caused by the leakage current of the SDD, which leads to a continuously rising output signal level. This is a normal behavior.

Please refer to Tab. 6 on page 6 for detail on the signal characteristics.



5.2 Digital output signal (AXAS-D only)

The AXAS-D includes a high-performance digital pulse processor (VICO-DP) so no other signal processing units are necessary. This unit can be connected to a PC via USB or RS232 interface. For details on the included software please refer to the VICO-DP manual in appendix.

5.3 Reading the temperature

The temperature of the SDD chip can be measured by using the integrated temperature readout circuit.

The TMP output (see Fig. 1b) provides positive voltage which is measured with a high ohmic ($\geq 1 \text{ M}\Omega$) multimeter. This output is buffered and cannot exceed 5 V DC. Typically it is below 2 V DC.

The thermistor whose resistance varies with the changing temperature is supplied with a constant current. As a consequence the thermistor voltage is related to the thermistor temperature.

To determine the SDD temperature it is necessary to measure the TMP out voltage and to compare the measured value with look-up table Tab. 8 below.



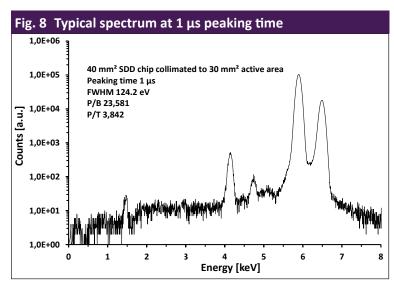
Tab. 8 Voltage at TMP output vs. SDD chip temperature							
Temp [°C]	Output [mV]	Temp [°C]	Output [mV]	Temp [°C]	Output [mV]	Temp [°C]	Output [mV]
-70	1894.3	-47	479.9	-24	117.5	-1	33.5
-69	1798.3	-46	450.5	-23	110.9	0	31.8
-68	1705.3	-45	423.0	-22	104.6	1	30.2
-67	1615.3	-44	397.2	-21	98.8	2	28.8
-66	1528.5	-43	373.0	-20	93.3	3	27.4
-65	1445.0	-42	350.3	-19	88.2	4	26.0
-64	1364.9	-41	329.0	-18	83.3	5	24.8
-63	1288.1	-40	309.1	-17	78.8	6	23.6
-62	1214.8	-39	290.4	-16	74.5	7	22.5
-61	1144.9	-38	273.0	-15	70.5	8	21.4
-60	1078.3	-37	256.6	-14	66.7	9	20.4
-59	1015.1	-36	241.2	-13	63.1	10	19.4
-58	955.1	-35	226.9	-12	59.8	11	18.5
-57	898.2	-34	213.4	-11	56.6	12	17.7
-56	844.4	-33	200.8	-10	53.6	13	16.9
-55	793.6	-32	189.0	-9	50.8	14	16.1
-54	745.6	-31	177.9	-8	48.2	15	15.4
-53	700.4	-30	167.5	-7	45.7	16	14.7
-52	657.8	-29	157.8	-6	43.4	17	14.0
-51	617.6	-28	148.7	-5	41.1	18	13.4
-50	579.9	-27	140.1	-4	39.1	19	12.8
-49	544.5	-26	132.1	-3	37.1	20	12.22
-48	511.1	-25	124.6	-2	35.2	21	11.68

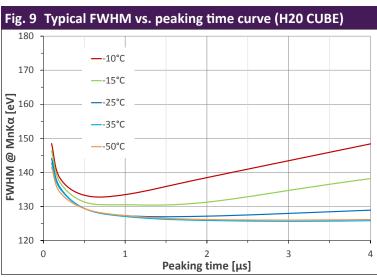
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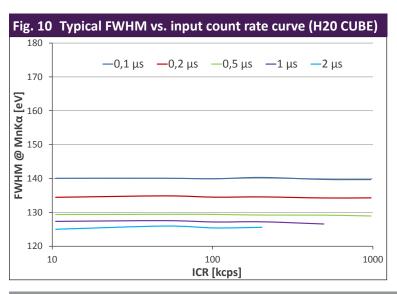


5.4 Spectroscopic performance

Typical performance is shown in the following graphs.









6 Troubleshooting

This AXAS-A/D unit has passed the quality control and the functional test. Thus no technical malfunction is expected during the operation. However if you are experiencing an unusual behavior of the system please read the instructions below. In case the existing problem is not listed or the proposed actions did not solve the issue please contact the KETEK support team. In addition if you are using the AXAS-D with the VICO-DP digital pulse processor please refer also to the VICO-DP manual in the appendix.

Issues	Possible solutions
PWR LED remains off	 The power supply of the AXAS-A/D is not working properly: Please check the POWER connector. When using the KETEK APS-L please check if the PS provides ± 12 V. If not the fuse of the APS-L might be blown. Please use 0.4 A and 250 V fuse for the replacement.
	2. The AXAS-A/D has a reverse current protection. In case your are using a custom power supply be sure that the polarity of the connector is correct. If the power supply is working correctly and the PWR LED still remains off please contact KETEK for more details.
PWR LED is on but RDY LED remains off	 The desired chip temperature has not been reached and the best performance of the system cannot be guaranteed. Please wait at least 60 sec. after powering up the device. Be sure that the ambient temperature inside the system where AXAS-A/D unit is being operated not exceeds 50 °C. Check if the detector is intact.
No ramped signal output	Be sure that the power supply is properly connected and working. Check if the PWR and RDY indications are on.
Poor FWHM performance	 KETEK specifies the full width at half maximum for Mn Kα peak with ⁵⁵Fe as an x-ray source. The FWHM performance is directly related to the detector temperature. Thus be sure the specified detector temperature has been reached. The other electrical devices near the detector, e.g. the x-ray tube, can induce a noise in the spectrum. Be sure that other devices are electrically decoupled from the SDD detector. Please assure that your FWHM calculation algorithm meets the definition of the ISO 15632 standard.
Peak tailing exceeds the specification	 KETEK specifies the peak to tail (P/T) for Mn Kα, as a ratio of Mn Kα to the mean value of the spectrum between 5.26 keV and 5.32 keV. Check if the RDY indication is on. Be sure that the gap time and the peaking time of the DPP is set properly.
Expected element not visible in spectrum	 Please be sure that the detector is placed as close as possible to the specimen. If operated under free air condition, especially the light elements are easily absorbed in the air. Please notice that due to physical limits of the SDD (absorption of the silicon layer), it is challenging to detect heavy elements with the characteristic x-ray energy above 30 keV (corresponding absorption around 17 %).

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7 Beryllium hazard procedure



WARNING

If the beryllium detector window is broken, do not inhale the beryllium particles in any case and proceed as described in this chapter

Beryllium window damage emergency procedure

- 1. Leave the area immediately and warn the entire stuff against entering the room.
- 2. Contact a medical doctor if you suspect breathing the beryllium in.
- 3. In case of the beryllium particles get in contact with your eyes, clean them with running water and consult a medical doctor.
- 4. In case of swallowing of the beryllium particles drink a lot of water and do not provoke vomits.

Beryllium window damage cleaning procedure

- Put on a breathing mask, protection suit and gloves before cleaning the damage beryllium window.
- 2. Prevent spreading of the beryllium particles in the air by closing all doors and windows in the room.
- 3. Collect all visible beryllium particles in a plastic bag, do not use a vacuum cleaner.
- 4. Put the AXAS-A/D in a second plastic bag.
- 5. Clean the entire area with cleaning wipes and put them in the first plastic bag. Seal both plastic bags.
- 6. Contact your local waste disposal contractor and dispose the first plastic bag.
- 7. Contact KETEK for a beryllium window replacement.

Please note that beryllium window damages are not covered under warranty.

The protection cup must be on if the AXAS-A/D is being moved, mounted or cleaned.

Keep the system protected from dust, sand, mud, fluids of any kind, direct sun exposure and other harsh environmental influences during the operation and storage.

Do not clean the detector in any case. The AXAS-A/D housing can be cleaned with soft and dry wipe only. Be sure not to move the dirt during the cleaning towards the detector.

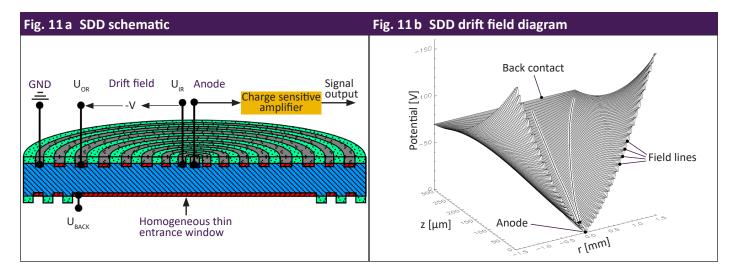
If the AXAS-A/D is not operated for longer time and freestanding please store it in the provided case.

Please refer to the section 3.2 for the maximum allowed ambient condition parameters.



8 SDD – simplified theory of operation

The silicon bulk of the Silicon Drift Detector (SDD) has to be depleted completely to make the sensor sensitive for incoming photons (Fig. 11 a). By applying a negative voltage to the back contact of the SDD, the detector bulk is completely depleted. An incoming photon will generate a number of electrons and holes dependent on its energy. The holes drift to the back side of the detector formed by the large area back contact whereas the electrons drift to the anode where the accumulated charge can be measured. The drift field for the electrons is applied by a ring structure on one side of the SDD with a negative voltage at the outer ring (Ring X) and a voltage close to 0 V at the innermost ring (Ring 1), as shown in Fig. 11 b.



The collected charge on the anode is directed to the charge sensitive amplifier. The CSA is available in two versions: FET and CUBE.

- FET: The anode is connected to the gate of the first field effect transistor (FET), the feedback capacitance (FB) and the cathode of the reset diode (RES). The combination of the FET and the feedback capacitance forms the first part of a charge sensitive amplifier, used to read out the accumulated electrical charge. The combination forms a trans-impedance (current to voltage) amplifier and an integrator when connected to the subsequent stages of the preamplifier. Therefore the source of the FET has to be connected to the ground. Moreover the drain voltage and current need to be set appropriately (typically 3 V and 3 mA). The operating point of the FET is optimized by setting its bulk or substrate voltage. The FET is operated in a common source configuration.
- CUBE: The anode is directly connected to the CUBE chip. The CUBE basically replaces the FET inside the SDD
 module. In comparison to the FET version the overall capacitance of the CUBE could be reduced by nearly an
 order of magnitude. This further reduces the rise time of a single signal step pulse. In consequence shorter peaking or shaping times in the pulse processing are possible. This provides a higher throughput, leading to shorter
 measurement time.
 - A second advantage is that the leakage current influence at shorter peaking or shaping times is much smaller. That helps to operate the CUBE SDDs at higher chip temperatures, leading to less power consumption for the TEC or Peltier element. Finally the CUBE provides an amplified and impedance converted signal.

The leakage current sensed at the anode causes a ramp signal at the output of the preamplifier, as mentioned in previous section. The slope of the ramp signal, and thus its frequency, is dependent on the operating temperature. The incoming photons generate short current pulses, with a certain rise time (dependent on the location of interaction of the x-ray with the SDD chip), and a certain duration and amplitude (dependent on the energy of the incoming photon). In turn, these short pulses generate steps superimposed on the preamplifier's ramped output signal. The height of a step contains the information necessary to determine the energy of the interacting photon.

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9 Contact

If you have any questions regarding this or any of our products please do not hesitate to contact us via e-mail or phone.

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Homepage www.ketek.net



10 Declaration of Conformity



Declaration of Conformity



We,

KETEK GmbH, Hofer Str. 3, 81737 Munich, Germany, declare under our sole responsibility, that the product

Name: Analytical X-Ray Acquisition System – Analog and Digital

Brand: KETEK – Creative Detector Solutions

Type, Model, Article No.: AXAS-A, AXAS-D

fulfills the requirements of the standard and regulations of the following directives:

I) <u>Directive 2014/30/EU</u> of the European Parliament and of the Council from April 20th, 2016 on the approximation of the laws of the member states relating to electromagnetic compatibility.

II) DIN EN 61326-1:2018-09 (IEC 61326-1:2018-09)

Electrical equipment for measurement, control and laboratory use; EMC – requirements; Part 1: general requirements.

- III) <u>Directive 2014/35/EC</u> Low Voltage Directive of the European Parliament and of the Council from February 26th, 2014 on the harmonization of the laws of Member States relating to electrical equipment designed for use within certain voltage limits.
- IV) <u>DIN EN 61010-1:2015-04 (Third Edition) Part 1 & A1 & A2 (IEC61010-1:2015-04)</u>
 Safety requirements for electrical equipment for measurement, control and laboratory use; Part 1: general requirements.
- V) <u>DIN EN 60068-2-27:2010-02 (IEC60068-2-27:20010-02)</u> Environmental tests, vibration tests, mechanical shock tests (mS).
- VI) Restriction of Hazardous Substances Directive RoHS 2 (including 2011/65/EU and 2015/863/EU) of the European Union from July 21st, 2011 restricting the use of ten hazardous and conflict materials in the manufacture of various types of electronic and electrical equipment. Documentation according to EN 50581:2012.

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VII) <u>Directive 2012/19/EU (WEEE)</u> of the European Economic Community (EEC) from February 2003 on waste electrical and electronic equipment, setting collection, recycling and recovery targets for all types of electrical goods.

Munich, January 22nd, 2021

Dr. Reinhard Fojt, CEO, KETEK GmbH

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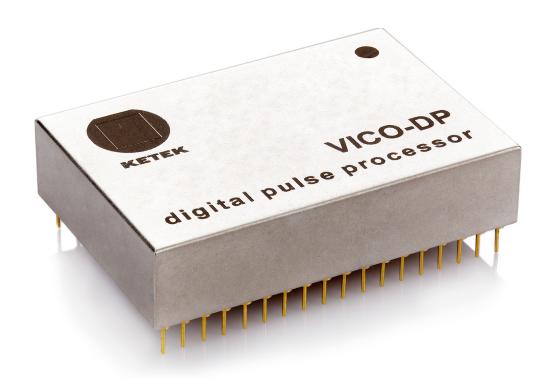
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Digital Pulse Processor

Manual







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Revision history:

Rev. 1.3, June 2020: Minor changes

Rev. 1.2, December 2017: Adapted to the ProSpect 1.1.14 Rev. 1.1, July 2017: Multichannel section 2.1.3 added

Rev. 1.0, June 2016



Dear Customer,

Thank you for choosing the KETEK VICO-DP. We ensure you that this product has been manufactured with highest industry standards in order to meet your quality expectations. Our highest priority is to deliver you the best product on the market.

The purpose of this start-up guide is to provide new KETEK VICO-DP users with an easy-to-use reference for getting to work with the ProSpect software application.

1 Safety instructions



NOTE

It is strongly recommended to keep to the instructions in this manual when installing the VICO-DP.

Please keep this user manual always with the system to allow any operator access to this important information.

The safety instructions are provided both for your protection and to prevent damage to the VICO-DP and connected equipment. This safety information applies to all operators and service personnel.

2 Product Description

The high-performance Digital Pulse Processor VICO-DP is a high-rate, digitally-based, multi-channel analyzer (MCA), designed for energy-dispersive X-ray measurements in benchtop, portable and embedded systems.

Its analog front-end is optimized for KETEKs preamplifiers. The VICO-DP offers computer control over all available amplifier and spectrometer parameters including gain, filter peaking time, and pileup inspection criteria. VICO-DP firmware and parameters are stored locally in non-volatile memory.

The VICO-DP features extremely short peaking times down to 100 ns and is optimized for KETEKs ASIC-based SDD modules.

The VICO-DP is available as a plugin module for KETEKS AXAS-A, AXAS-M and VICO-AV.



2.1 Features

2.1.1 General Spectrometer Features

- Dimensions: 46.55 x 31.3 x 11 mm³.
- Operates with all KETEK AXAS and VICO-DV.
- The VICO-DP requires several DC voltage supplies for operation. The VICO DP's power consumption is less than 1 Watt
- Multi-channel analysis with up to 8K (8192) bins allows for optimal use of data to separate fluorescence signal from backgrounds.
- Instantaneous throughput beyond 1,000,000 counts per second (cps).
- Digital trapezoidal filtering, with programmable peaking times between 100 ns and 24 µs in 24 steps.
- Digitally-controlled analog gain: 6 dB range, 2 discrete settings.
- Digital fine gain trim: 16-bit precision.
- Pileup inspection criteria computer settable, including fast channel peaking time, threshold, and rejection criterion.
- Accurate ICR and live-time reporting for precise dead-time corrections.

2.1.2 Embedded Systems Features

- Data acquisition and control via USB 2.0 high-speed or RS-232.
- Twenty-four (24) sets of optimized spectrometer parameters, or PARSETs, are stored and retrieved on a per-peaking-time basis in nonvolative memory.
- Five (5) sets of MCA parameters, or GENSETs, are stored and retrieved in nonvolative memory.
- The provided ProSpect software application for VICO-DP parameter set configuration—intended for use both in evaluation and production phases.
- DLL. The combination of ProSpect+DLL only works with Windows. The source code package for Windows or Unix is available on request.

2.1.3 Multichannel Operation

Several systems equipped with VICO-DPs can be connected to the same host PC and operated simultaneously.



NOTE

Multichannel operation is only possible in case of the systems with the same VICO-DP firmware version. Otherwise a reliable operation cannot be guaranteed. This could be the case if the systems have been purchased separately. Please contact KETEK for more details.

2.2 Hardware Requirements

HOST COMPUTER

The VICO-DP can communicate with any host computer/controller via USB or RS-232.



NOTE

The ProSpect software is only available for Windows operating systems!

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DETECTOR / PREAMPLIFIER

The VICO-DP accommodates all KETEK detector preamplifier signals. The voltage compliance range in the analog circuitry imposes the following constraints.

Tab. 1 Analog input sig	. 1 Analog input signal constraints for pulsed-reset preamplifiers					
Parameter	Minimum	Maximum	Typical			
X-ray pulse-height	1.5 mV	400 mV	30 mV			
Input voltage range	-	+/-4 V	+/-2 V			

2.3 Hardware Options

2.3.1 Communications

The VICO-DP supports USB2.0 high speed and RS-232 at 921 kbaud. KETEK recommends using the MAX3224E/MAX3245E module or similar for maximum RS-232 communication speed.

2.3.2 Analog Input

The analog input signal enters the VICO-DP directly from the preamplifier. For some KETEK systems (AXAS-D and VICO-DV) the analog preamplifier signal is also connected to an external connector for control of this signal.

2.3.3 Gain and Calibration

The variable gain option provides 6 dB of digitally-controlled analog gain in two discrete steps in addition to the digital gain. This allows the VICO-DP to be optimized for a wide range of X-ray energies.

2.4 Software Overview

Up to three layers of software may be employed in a VICO-DP instrumentation system:

- A user interface layer (ProSpect)
- A driver layer that communicates between the user interface and the hardware (DLL)
- A firmware layer

2.4.1 User Interface, e.g. ProSpect

ProSpect is offered as a general-purpose configuration and data acquisition application.

For instructions on using the ProSpect GUI with the VICO-DP, please refer to §3.

2.4.2 Device Drivers, e.g. Handel (DLL)

KETEK provides source code for the high-level spectrometer driver layer that operates with the VICO-DP.

The Handel interface works with basic units (eV, microseconds, etc...) while still allowing for safe, direct-access to the VICO-DP. Please contact KETEK for further information.



2.4.3 Firmware

The VICO-DP operates with a relatively simple command set, accommodating easy implementation into embedded systems. The firmware is not intended to be updated by the user.

3 The ProSpect Software

ProSpect is the User Interface for configuring the VICO-DP settings, for performing diagnostic tasks, and for acquiring and exporting spectra.

ProSpect works with Windows 7 and higher. The latest software update can be downloaded from the the KETEK web-

3.1 Installation

- 1. Close all applications that are currently running.
- 2. Double-click the installation executable.
- 3. Follow the instructions to install ProSpect and Handel.

When the ProSpect installation is finished, a shortcut to the application will be located on your desktop. A copy of Adobe Acrobat Reader® is required to view the help files distributed with ProSpect. If you need to install Adobe Acrobat Reader®, please do so from the Adobe website:

https://acrobat.adobe.com/us/en/products/pdf-reader.html

FILE LOCATION

The default location of the ProSpect executable after installation is C:\Program Files (x86)\XIA\ProSpect 1.x

3.2 Starting ProSpect for the First Time

ProSpect must first determine to which USB or COM (RS-232 serial) port the VICO-DP is connected, and store that information in a configuration (INI) file.

The VICO-DP boots itself upon power-up, and is shortly (about 5 s) thereafter ready to acquire data with the same set of operating parameters used in the previous run. The first time the VICO-DP is powered on, detector- and preamplifier-related parameters will be in the factory default state.

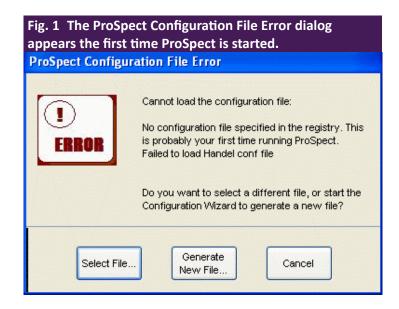


⚠ NOTE

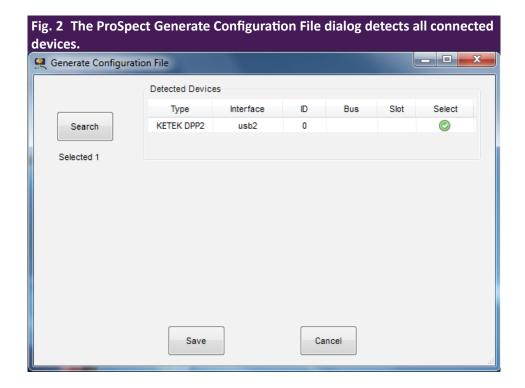
The VICO-DP requires approximately 5 seconds to boot up, during which time the device can be recognized but cannot be initialized by the host.

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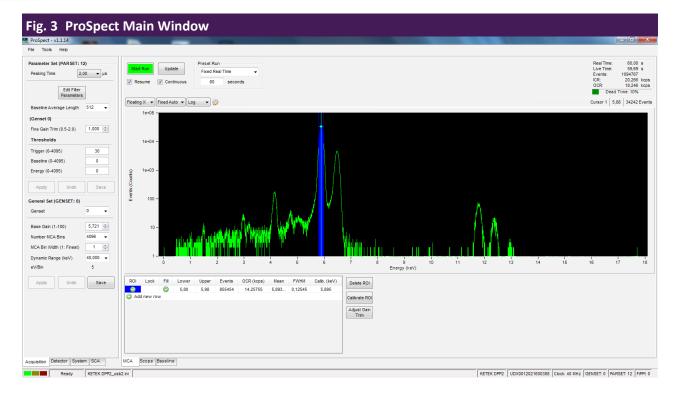


The settings should be optimized and saved to the non-volatile on-board memory so that they will automatically load during subsequent boot operations. The first time ProSpect is started, an error dialog will appear, indicating that no INI file was specified. See Fig. 1.



- 1. Click the [Generate New File...] button to open the **Generate Configuration File** dialog, which displays all detected devices.
- 2. Click in the Select column next to the detected VICO-DP.
- 3. Click the [Save] button to generate an appropriate INI file and proceed with initialization





3.3 A Tour Through the Basic ProSpect Features

The Main Window is divided into two panels: The Settings Panel on the left and the larger Main Panel on the right. Both panels are tabbed. In Fig. 3, the **Acquisition** and the **MCA** table are selected.

3.3.1 The Settings Panel

The Settings panel contains four tabs:

- Acquisition
- System
- SCA
- Detector

In this guide, we will limit the scope to the **Acquisition** and **Detector** tabs.

In the uppermost section, the **Acquisition** tab provides access to **Peaking Time** selection.

The two sections below contain peaking-time-related PARSET settings and the MCA-related GENSET settings parameters.

The **Settings** panel is intended to be the primary interface for setup and optimization as well as data acquisition, and is referenced throughout the following paragraphs. The Detector tab contains global (GLOBSET) settings related to the detector type and preamplifier characteristics, as described in §3.4.

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3.3.2 The Main Panel

The Main panel contains three tabs:

- the MCA spectrum display tab
- the Scope tab
- the Baseline tab

The MCA tab is the default tab, while the Scope and Baseline tabs are for diagnostics

The MCA tab displays the acquired energy spectrum in the plot area and run statistics, e.g. input count rate, real time, etc., in the Statistics area at the top. Statistics for-user specified spectral regions of interest (e.g. ROI-selected peak mean and FWHM) are displayed in the ROI Controls area at the bottom.

The **Scope** tab is an oscilloscope tool for viewing digital signal vectors.

The **Baseline** tab displays the diagnostic baseline histogram and baseline history data. Zooming and panning in all three **Main** panel tabs can be customized by using the **Display Controls** in conjunction with mouse operations both on the axes and in the plot area.

The **Status Bar** along the bottom contains information about the state of the hardware and software, and the hardware serial number. The status indicator at the lower left corner of the main window changes to yellow during RS-232 or USB communications, green when idle and red when an error has been detected.

3.3.3 Preview of the Setup Process

The VICO-DP has been designed for ease-of-use in embedded applications. ProSpect can be used to first optimize detector and preamplifier settings and all the parameters associated with each of the 24 **Peaking Times** in combination with up to 5 MCA spectrum formats and then save them to non-volatile memory.

Once setup is complete, the client software application only needs to switch between PARSETs to select the desired **Peaking Time** and MCA spectrum format to retrieve all the optimized settings from non-volatile memory.

The setup process comprises three steps:

- 1. Configuring the detector preamplifier settings,
- 2. Adjusting the MCA format,
- 3. Optimizing the parameters linked to each **Peaking Time**.

3.3.4 Parameter Settings: GLOBSET, PARSETs, and GENSETs

Three different types of parameter tables are stored in non-volatile memory: GLOBSET, PARSET, and GENSET.

GLOBSET

The singular GLOBSET is accessible in the **Detector** tab. It contains global settings including detector/preamplifier settings and preset run controls. There is only one GLOBSET. These global settings are used for all peaking times and MCA formats. Changes to these settings are simultaneously applied and saved to nonvolatile memory via the [Apply / Save] button.



PARSET

The PARSET table is accessible in the top half of the **Acquisition** tab. It includes all peaking-time-dependent settings, e.g. thresholds, sampling interval, etc.

Selecting a new Peaking Time automatically loads a unique set of parameters stored for that peaking time.

There is a complete PARSET table stored in non-volatile memory for each Peaking Time. To maintain energy calibration and proper triggering across every combination of PARSET and GENSET, each PARSET in fact includes **Fine Gain Trim** values and five sets of thresholds; one for each GENSET.

GENSET

The GENSET table is accessible in the bottom half of the **Acquisition** tab. It defines the number of bins and granularity of the MCA spectrum, as well as the **Base Gain**. Five GENSET tables can be stored, allowing for five different optimized MCA formats. Typically though, only the first GENSET, i.e. GENSETO, is used.

3.4 Detector/Preamplifier (GLOBSET) Settings

The global parameter set, or GLOBSET, includes detector type and preamplifier characteristics, accessible in the **Detector** tab of the **Settings** panel (see Fig. 5). ProSpect automatically determines the preamplifier type based upon the firmware installed in non-volatile memory.

The detector settings always include the signal **Polarity**. For reset-type preamplifiers, the **Reset Interval**, the period of time following the preamplifier reset during which data acquisition is disabled, is also included.

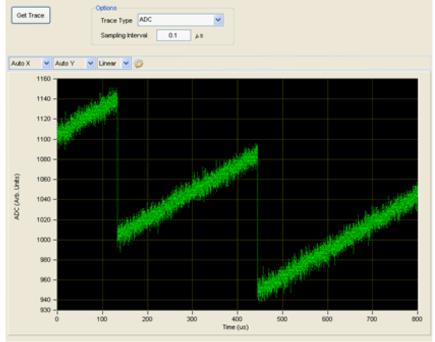
3.4.1 Viewing the Preamplifier Signal

- 1. Select the **Scope** tab in the Main Panel, which acquires and displays the digital signal vectors from the VICO-DP. See Fig. 4.
- 2. Select ADC from the Trace Type drop-down list.
- 3. Click the [Get Trace] button to refresh the display.

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Fig. 4 Scope tool, displaying a series of two X-ray pulses from a reset-type preamplifier. Note that pulses have falling edges, indicating that the polarity setting is wrong.



The **Sampling Interval** field controls the time interval between individual points, thus larger values will result in a longer displayed period. The minimum value of 25 ns (for 40 MSPS ADC) results in a displayed period of approximately 200 µs. A detailed discussion of the **Scope** tool diagnostics can be found in §3.8.3.

3.4.2 Setting the Polarity

We recommend that you review §3.8.3 for an introduction to the **Scope** tool. The DDP2's digital filters expect positive X-ray pulse-steps, i.e. with a rising edge.

If the displayed X-ray steps have a falling edge, as in Fig. 4, the detector **Polarity** setting must be modified. If the displayed X-ray steps have a rising edge (as in Fig. 5), the VICO-DP polarity setting is correct—proceed to the next section.

To change the **Polarity** setting:

- 1. Select (+) Positive or (-) Negative from the drop-down list.
- 2. Click the [Apply/Save] button to apply the new setting.
- 3. Store it to non-volatile memory.
- 4. Click the [Get Trace] button again to verify positive pulse-steps.

3.4.3 Setting the Reset Interval (Reset-Type Preamplifiers)

Reset preamplifiers produce a large corrective reset step when the large-signal 'staircase' waveform reaches its limit. This reset transient varies for different preamplifiers, both in the duration and in other signal characteristics, e.g. rise time, charge-injection, overshoot and settling time.

Data acquisition should be disabled during the transient. If it is not, artifact events can be introduced into the spectrum and resolution can be degraded due to corruption of the baseline measurement. The **Reset Interval** sets the duration after a preamplifier reset is detected during which baseline and event acquisition is disabled.



The default Reset Interval of 5 µs should work reasonably well for KETEKs SDDs. In any case, the setting is best optimized after gain and threshold settings have been chosen, which affect baseline acquisition. Preamplifier reset transients, and how to properly set the Reset Interval, are discussed in §3.8.3.3.

3.5 MCA (GENSET) Settings

The general parameter set, or GENSET, includes the Base Gain and the Number MCA Bins, MCA Bin Width, and other settings that define the MCA spectrum. Up to five complete GENSETs can be modified and stored such that five optimized MCA formats can automatically be retrieved simply by selecting the GENSET parameter.

Here, we simply want to prepare GENSETO with some basic settings.

3.5.1 Gain Overview

We can express the MCA Bin corresponding to an X-ray with voltage amplitude $\Delta V_{_{Preamp}}$ in terms of ProSpect settings and hardware settings, as:

$$eV / Bin = \frac{Dynamic Range \cdot MCA Bin Width}{8000}$$

A separate bin width setting defines the granularity, and thus the file size, of the MCA energy spectrum.

The change in gain architecture is transparent at the ProSpect application level, i.e. the Handel driver determines the hardware revision and variant, and automatically adjusts the analog and digital gain according to the original acquisition values: Base Gain and Fine Gain Trim. As before, the bin size (eV/Bin) of the MCA spectrum is determined by the MCA Bin Width and Dynamic Range settings.



NOTE

Please note that since ProSpect 1.1.14 the variable corresponding to the low/high gain setting is twice of the previous value, meaning 5.7 means high gain setting (2.8 before).

3.5.2 Setting the Dynamic Range

The **Dynamic Range** is a software-only setting that assigns an energy in kilo-electron-Volts (keV) to an X-ray voltage pulse that spans roughly 50% of the ADC input range, a practical measurement limit.

Along with the MCA Bin Width, it determines the energy scale of the MCA spectrum, i.e. the MCA bin size (eV/bin).

The **Dynamic Range** setting should correspond to the highest measurable energy, respective of the detector, preamplifier and experimental conditions. A typical X-ray dynamic range is 40 keV or 80 keV, though some AP3 detectors intended for low-energy X-rays may work best with the minimum 20 keV setting. At very high count rates a larger Dynamic Range setting can improve throughput. Because this is a software-only setting, it is applied immediately upon selection from the drop-down list.

3.5.3 Setting the Base Gain

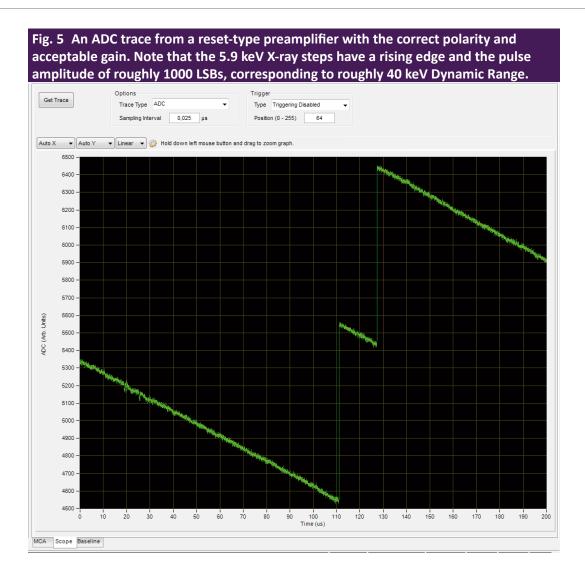
The Base Gain setting, associated with the GENSET, in fact combines the coarse analog Switched Gain and Digital Base Gain acquisition values into a single 'gain knob' with a range of 1-100. It should be set according to the dynamic range of the input signal: large enough that electronic noise is sufficiently digitized, but small enough that the largest X-rays of interest fit well within the ADC input range.

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NOTE

Setting the Base Gain too low will result in insufficient digitization of the electronic noise, and thus degraded energy resolution, because optimal energy resolution relies on noise averaging. On the other hand, setting the Base Gain too high will result in higher deadtime and the attenuation of the high energy X-ray peaks, because pulses with larger heights are more likely to force the ADC signal out-of-range, and such events cannot be processed into the spectrum.



As a rule of thumb, the largest X-rays of interest should span no more than 50% of the ADC input range.

The default **Base Gain** setting serves as an adequate starting point for most detectors. If the Preamplifier Gain is known, use the equation below to choose the preliminary **Base Gain** setting.

SCOPE TOOL

Use the **Scope** tool to check the **Base Gain** setting. You should have already verified the signal polarity, such that pulses are displayed with a rising edge as described in §3.4.2. For best results the X-ray pulses with an energy equal to the Dynamic Range should be digitized at roughly 50% of the ADC range, or 8000 out of 16,384 least-significant-bits (LSBs). X-rays with other energies should of course be scaled accordingly.



3.5.4 MCA Format

The DDP2 MCA format is quite flexible, with adjustable **Number MCA Bins** ranging up to 8192, and adjustable granularity via the **MCA Bin Width** setting. The DSP doesn't constrain the relationship between these settings, so it's possible to define a spectrum that exceeds the practical limits of the ADC, i.e. such that the MCA energy range significantly exceeds the **Dynamic Range**, which should be avoided. As a rule-of-thumb, the product of **Number MCA Bins** and **MCA Bin Width** should not exceed 8192.

Tab. 2 Bin Size and Energy Range as a function of Number MCA Bins and MCA Bin Width, with a Dynamic Range of 40 keV. Note that the product of Number MCA Bins and MCA Bin Width is always 8192 or less.					
Number MCA Bins	MCA Bin Width	Bin Size	Energy Range		
8192	1	5 eV	40.96 keV		
8000	1	5 eV	40.00 keV		
4096	1	5 eV	20.48 keV		
4000	1	5 eV	20.00 keV		
4096	2	10 eV	40.96 keV		
4000	2	10 eV	40.00 keV		
2048	1	5 eV	10.24 keV		
2000	1	5 eV	10.00 keV		
2048	2	10 eV	20.24 keV		
2000	2	10 eV	20.00 keV		
2048	4	20 eV	40.96 keV		
2000	4	20 eV	40.00 keV		

When the product equals 8000, the energy range of the MCA spectrum is exactly equal to the **Dynamic Range**, corresponding to voltage pulses that span 50% or less of the ADC input range, a practical measurement limit.

Energy Range = Number MCA Bins · eV/Bin

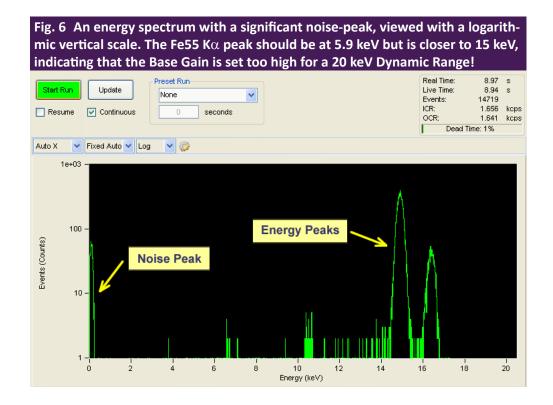
A few examples are shown in Table 4 above, all with the Dynamic Range equal to 40 keV.

Which setting is the best depends on the required bin size, energy range and spectrum file size for a given application.

Note that the default setting is 4096 bins with MCA Bin Width equal to 1.

- 1. First select the desired Number of MCA Bins.
- 2. Set the MCA Bin Width such that the product is less than or equal to 8192.
- 3. Click [Apply] to download the new settings to hardware.
- 4. Click [Save] once you have verified the settings.





3.6 Spectrum Acquisition

At this point the **Polarity, Base Gain, Dynamic Range, Number MCA Bins** and **MCA Bin Width** should have been set as described in § 3.4 and § 3.5 above. Before saving the GENSET settings, however, the Base Gain should be calibrated from an actual energy spectrum.

Proceed as follows:

1. Click on the MCA tab.

The **MCA** tab displays the distribution of measured pulse-heights and thus, after calibration, the energy spectrum of the incident photons.

2. Click the [Start Run] button to begin a data acquisition run.

If the **Continuous** checkbox is selected, the display will refresh automatically. Otherwise data will only be displayed after clicking the [Update] button and/or after the run is stopped.

An uncalibrated energy spectrum should now be displayed. Click [Stop Run] to end the spectrum acquisition run. A noise peak near channel zero (0) might be displayed if the gain is set too high or a threshold is set too low.

If the noise peak overwhelms the energy peak, or if no data is displayed it is likely that the Polarity and/or Base Gain has not been set properly—please review §3.4 and §3.5 above before continuing.



3.6.1 ROI Selection

In order to calibrate the energy we must first designate the calibration peak with a Region of Interest (ROI). By default the ROI table should display as in Fig. 7 A.

1. Click on the Add New Row icon to add the first ROI.

Up to sixteen (16) ROIs can be added, with the Mean, FWHM, OCR and total number of Events displayed for each.

- 2. Right-click in the spectrum display of the MCA tab.
- 3. Select Place Cursor 1.
- 4. Use the left mouse button to drag the cursor within the desired peak, zooming in if necessary using the mouse shift-click + drag operation.

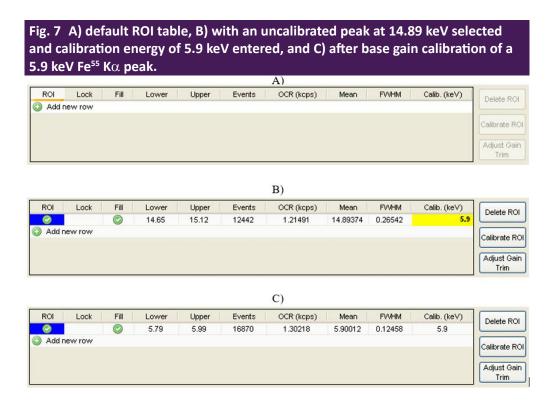
Hint: right-click and select Full Scale to display all data.

- 5. Right-click on cursor 1.
- 6. Select Auto ROI.

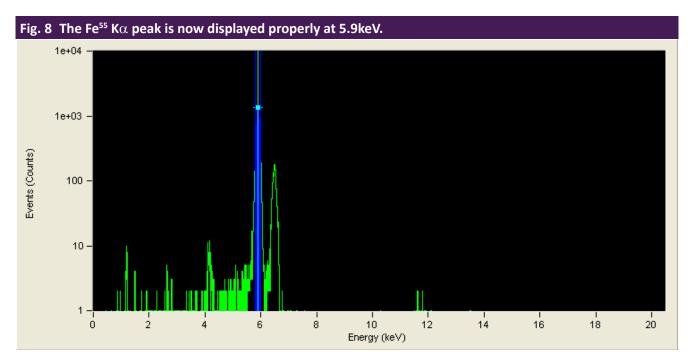


NOTE

If the Base Gain was modified significantly enough in step 1 above to change the coarse analog Switched Gain setting, the calibration may still be off by up to 1%. In this case, repeat as necessary to achieve the desired accuracy. Another consequence is that the thresholds may need to be re-optimized, so it's important to get the Base Gain right before proceeding to § 3.7.







A shaded region of interest should appear within the peak. If the number of counts in the peak is insufficient, the auto ROI function will not adequately select the peak.

If necessary, the ROI limits can be adjusted directly:

- Use the left-mouse click-and-drag operation or
- Edit the Lower and Upper fields in the ROI table.

The ROI table should now display as in Fig. 7 B.

The software will scale the active ROI (denoted by the check mark in the far-left column of the table) to the calibration energy. ROIs can be locked by clicking in the **Lock** column.

3.6.2 Base Gain Calibration

Once a known energy peak has been selected with the active ROI, as described in §3.6.1, the Base Gain can be calibrated.

At this point the **Fine Gain Trim** should be at its default value of 1.000. If this is not the case:

- 1. Reset the **Fine Gain Trim** in the PARSET area of the Acquisition tab to 1.000.
- 2. Click the [Apply] button below.
- 3. Enter the energy of selected peak in keV units in the Calib. (keV) field of the ROI table.
- 4. Click the [Calibrate ROI] button to automatically adjust the Base Gain. Note that the Base Gain was modified as a result.
- 5. Click the [Start Run] button to acquire more data.

Note that the spectrum should now be calibrated as in Fig. 7C. If the ROI is properly adjusted, the **Mean** field in the **ROI** table should match the calibration energy entered as in Fig. 7C.



Once you are satisfied with the MCA settings and energy calibration, click the [Save] button in the GENSET area of the **Acquisition** tab.

3.7 Peaking Time (PARSET) Optimization

For each of the twenty-four **Peaking Time** values the DSP stores a complete set of all related spectrometer parameters into non-volatile memory, i.e. into the corresponding PARSET. The 24 parameter sets (PARSETs) are first optimized and saved to the on-board non-volatile memory.

Subsequent selection of an optimized **Peaking Time** retrieves all relevant digital filtering and peak inspection parameters (e.g. gap time, thresholds, pileup inspection interval, etc.). This functionality is targeted at embedded systems: the configuration and optimization procedures can be performed in the lab using the ProSpect software, such that only a small command set is required within the embedded system itself, e.g. start run, stop run, change PARSET (peaking time), etc.



The configuration process needs only be performed once, though of course the parameter sets can later be modified.

Peaking Time (PARSET) selection and the most commonly used parameter settings are accessed directly from the **Acquisition** tab of the **Settings** panel.

- » Click [Edit Filter Parameters] to access less frequently used parameters.
- >> Select the desired **Peaking Time** from the drop-down list.



The following sections describe the process of selecting and storing the individual parameters for one peaking time.

3.7.1 Threshold Settings

Three thresholds can be used simultaneously to distinguish noise from X-ray events. Whereas noise goes into the baseline distribution, X-ray events go into the energy spectrum.

Each of these thresholds has its own balance of timing vs. noise performance.

- The fast-filter **Trigger** threshold achieves the best pulse-pileup rejection.
- The slow-filter **Energy** threshold can be used to detect the lowest energies.
- The intermediate-filter **Baseline** threshold is somewhere in the middle.

Thresholds can be individually disabled by setting them to zero (0).

The thresholds are typically the most important PARSET settings to get right. By default they are set conservatively, however, better performance will be achieved when the thresholds are set as described below.

We recommend saving the PARSET after each threshold is verified, by clicking the [Save] button.

Finally, note that if the Base Gain is subsequently changed by a significant amount, i.e. by enough to change the coarse analog Switched Gain, the thresholds must be re-optimized and the PARSET saved again. For this reason it's important to first get the Base Gain right as described in §3.6.2.

3.7.1.1 Disable the Slow Threshold

By default the Energy threshold is disabled, and it should be disabled, i.e. set to zero (0), in nearly all cases.

Although its excellent noise reduction also allows detection of the very lowest energy X-rays, its slow response precludes an accurate determination of deadtime. This results in both degraded pulse pileup inspection and an error in the input count rate calculation. The **Energy** threshold should thus be used only when low-energy X-rays of interest are present that can't otherwise be detected using the other thresholds, and only then with the understanding that pileup inspection for such events is marginal at best.

3.7.1.2 Trigger Threshold

By default the Energy threshold and the Baseline threshold should be disabled, i.e. set to zero (0).

If this is not the case

- 1. Set both values to zero now.
- 2. Click [Apply].

Depending on the system, an appropriate **Trigger** threshold value is provided.

- 3. Edit the value as necessary.
- 4. Click [Apply].
- 5. Click [Start Run] to acquire data in the **MCA** tab.
- 6. Click [Stop Run].

If the noise peak is NOT displayed:

- 7. Reduce the **Trigger** threshold by a factor of 2.
- 8. Repeat steps 5 to 7 until the noise peak is visible.
- 9. When the noise peak is displayed, increase the Trigger threshold in smaller increments.



- 10. Repeat until the noise peak is eliminated.
- 11. Take note of the input and output count rates (ICR and OCR) for the next section.
- 12. Click the [Save] button in the PARSET area of the **Acquisition** tab.

3.7.1.1 Baseline Threshold

Disable the Baseline and Energy thresholds (set to zero (0)). The Trigger threshold has been set to a good value before as described in the previous chapter.

In most cases a starting value of roughly 100 for the **Baseline** threshold is appropriate.

- 1. Edit the value.
- 2. Click [Apply].
- 3. Click [Start Run] to acquire data in the MCA tab.
- 4. Click [Stop Run].

If the noise peak is NOT displayed:

- 5. Reduce the **Baseline** threshold by a factor of 2 and
- 6. Repeat steps 3 to 5 until the noise peak is visible.
- 7. When the noise peak is displayed, increase the **Baseline** threshold in smaller increments.
- 8. Repeat until the noise peak is eliminated.

Note that in most cases the **Baseline** threshold will have very little effect on the input and output count rates.

9. Click the [Save] button to save the new Baseline Threshold to the current PARSET.

3.7.2 Fine Gain Trim

Now we are ready to trim the gain for this peaking time.

Remember, the Base Gain was stored in the GENSET.

The Fine Gain Trim, or per-peaking-time calibration, is stored in the PARSET. There is a Fine Gain Trim value stored for every PARSET/GENSET combination, allowing for a unique overall gain setting for each combination.

- 1. Select a known peak in the MCA spectrum.
- 2. Enter its energy in the Calib. (keV) field of the ROI table, if it hasn't been entered already.

Make sure the selected ROI is active, i.e. it has the green check mark in the left-most column of the table!

3. Click the [Adjust Gain Trim] button to automatically adjust the Fine Gain Trim. Note that the Fine Gain Trim has been modified but the Base Gain has not.



NOTE

The Overall Gain also includes the Fine Gain Trim value that is associated with each Peaking Time, i.e. stored in each PARSET, to maintain the gain calibration on a per-peaking-time basis, as described in § 3.7.3.



- 4. Click the [Start Run] button to acquire more data. Compare the Mean energy in the ROI table to the calibration energy entered.
 - 5. Repeat steps 3 and 4 until the fields match the required precision.
 - 6. Click the [Save] button to save the Fine Gain Trim to the current PARSET.

3.7.3 Optimization of the Remaining PARSETs

We're now ready to repeat the above process for each of the remaining twenty-three PARSETs, or perhaps only those that will be used. Set and verify the thresholds and then save each PARSET to non-volatile memory:

- 1. Write down the Trigger and Baseline threshold settings for your optimized PARSET.
- 2. Select the next Peaking Time from the drop-down list.
- 3. Enter the values from step 1 above.
- 4. Click [Apply].

Don't re-optimize the Trigger threshold unless the Fast Trigger Filter Peaking Time (aka FASTLEN) has changed. By default all PARSETs have a Fast Trigger Filter Peaking Time of 50 ns (FASTLEN=2),

Note that the Fast Trigger Filter Peaking Time is displayed in the Edit Filter Parameters dialog as described in § 3.7.4.

If you are changing from a shorter Peaking Time to a longer one, the Baseline threshold can likely be reduced a bit. Optimize the Baseline threshold as described in §3.7.1.1.

- 5. Calibrate the Fine Gain Trim as described in §3.7.2.
- 6. Repeat steps 1-5 above for each remaining Peaking Time, making sure to [Save] often.

Now you have completed the basic configuration and optimization!

If you do not achieve satisfactory performance after following the above procedure, continue reading § 3.7.4 below, which includes:

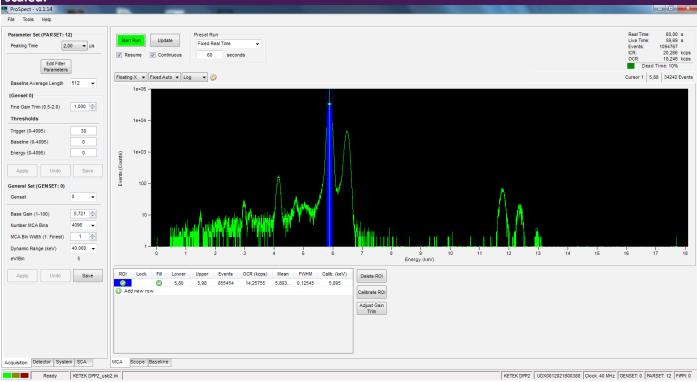
- Adjusting the slow gap time for longer preamplifier rise times, as described in §3.7.4.1.
- The Peak Capture Method at short peaking times may need adjustment, as described in §3.7.4.2.
- Adjustment of the Fast Trigger Filter and pileup inspection parameters is described in §3.7.4.3.

3.7.4 Advanced Optimizations

See Fig. 11 for the advanced settings for the current Peaking Time. Changing any of these parameters can significantly alter the performance of VICO-DP at the selected Peaking Time.



Fig. 10 Calibrated Fe55 spectrum viewed with a logarithmic vertical scale. An ROI has been created and calibration energy entered, and thus the horizontal axis of the MCA and the measured centroid and FWHM have been scaled.

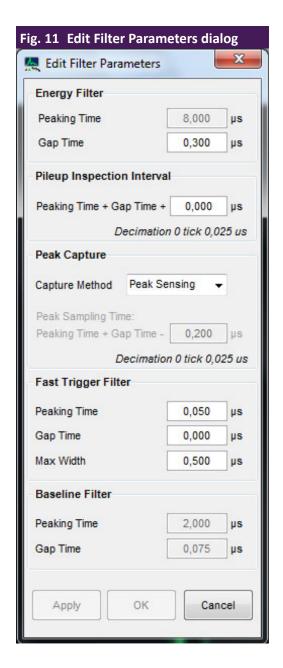


- 1. Go to the **Acquisition tab** in the Settings Panel. See Fig. 10.
- 2. Click the [Edit Filter Parameters] button in the PARSET area of the Settings Panel.

This dialog displays the parameters that control the digital filtering algorithm.

- 3. Make sure the desired Peaking Time is selected from the drop-down list.
- 4. Click [Edit Filter Parameters] to open the Edit Filter Parameters dialog.
- 5. Edit the parameters of interest (e.g. Energy Filter Gap Time, Capture Method, Fast Trigger Filter Peaking Time, etc.).
- 6. Click [OK] to apply the changes and close the dialog, or click [Apply] to apply the changes but keep the dialog open for further editing.
- 7. Click [Start Run] to acquire data for comparison in the MCA tab.
- 8. Click [Stop Run].
- 9. [Save] the PARSET to store the modified parameters to non-volatile memory such that they will be retrieved the next time the Peaking Time is selected.





3.7.4.1 Preamplifier Rise Time: SLOWGAP

The **Energy Filter Gap Time** is visible as the 'flat-top' region of the energy filter output trapezoid. SLOWGAP is typically set such that the flat-top interval is longer than the longest rise time of the preamplifier output pulses by at least one sampling interval:

Energy Filter Gap Time = SLOWGAP ⋅ sampling interval > rise time

In special cases where the very highest output count rates are desired, and perhaps at the expense of energy resolution or peak shape, the user may wish to set the gap time to be significantly less than the SDD's rise time.

The rise time is easily measured using the Scope tool:

- 1. Select ADC.
- 2. Set Sampling Interval to the minimum value by entering "0".
- 3. Click the [Get Trace] button.
- 4. Use the cursors to zoom in on an X-ray pulse, as in below.



Fig. 12 In this example plot the rise time is ~200 ns as indicated in the dX=0.20 field at the upper right corner. Get Trace Trace Type ADC Type Triggering Disabled Sampling Interval Position (0 - 255) 0.025 Floating X ▼ Floating Y ▼ Linear ▼ Delto Hold down left mouse button and drag to zoom graph. Cursor 1 | 33,175 | 12040 Events | dX=0,20 | dY=994 12950 12900 12850 12800 12750 12700 12650 12600 (Arb. Units) 12550 ADC 12500 12450 12400 12350 12300 12250 12200 12100 MCA Scope Baseline

In the example plot (Fig. 12) the cursors are used to zoom in and measure the preamplifier 0-100% rise time.

If the input signal displays a range of rise times, as in the case of ballistic deficit (large SDDs > 20mm²), the slow filter gap time should be extended to accommodate the longest rise times.

The Energy Filter Gap Time is constrained by the relationship between the slow energy filter and the intermediate baseline filter. The baseline filter length (BASELEN) and gap (BASEGAP) are always constrained to be exactly ½ or ¼ the energy filter length (SLOWLEN) and gap (SLOWGAP), respectively, depending on the Peaking Time.

This means that the energy filter length and gap increment, or units, must be either 2x or 4x the clock period, as shown in Table 5.



NOTE

ProSpect automatically enforces this relationship: It will round the user value up or down as necessary when the [Apply] or [OK] buttons are pressed. The relationship can be determined by the parameter BFACTOR:

"SLOWLEN= " "2" ^"(BFACTOR+1)" " * BASELEN"



NOTE

The Baseline Filter Peaking Time and Gap Time are displayed at the bottom of the Edit Filter Parameters dialog, but cannot be edited.



Example:

If the preamplifier rise time is 120 ns and the Peaking Time is 8 μ s, BFACTOR=1 and SLOWGAP has an increment of 4x the clock period.

With a 40MHz clock the SLOWGAP increment is 100 ns, and the correct setting is 200 ns.

- 1. Open the Acquisition tab.
- 2. Click the [Edit Filter Parameters] button.
- 3. Edit the Energy Filter Gap Time as necessary.
- 4. Click [OK].
- 5. Click [Save] to save the new value to the PARSET in the PARSET area of the Acquisition tab.

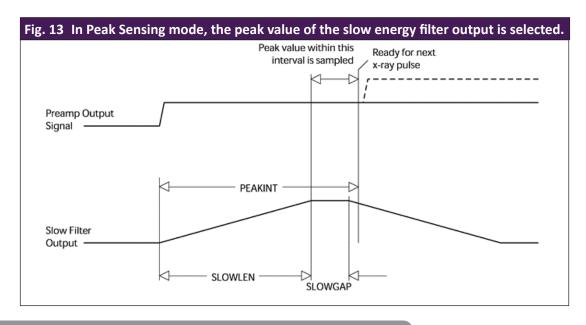
3.7.4.2 Peak Capture Method: Peak Sensing vs Peak Sampling

Two peak capture methods are supported by the VICO DP hardware. In general, the default Peak Sensing mode is recommended: it is 'automatic' and thus easier to use, and achieves the best pulse-height measurement in most cases.

At very short peaking times, and especially when the user sets the Energy Filter Gap Time to less than the preamplifier rise time, the Peak Sampling mode may yield better results. The precise setting has a strong effect on energy resolution and should be determined empirically for each new detector.

PEAK SENSING

In this mode, the energy filter output is monitored over a finite interval of time, and the maximum value within that interval is selected.





The interval is set automatically, based on the values of the parameters SLOWLEN and PEAKINT. PEAKINT is also a pileup inspection parameter, as will be discussed in further detail in § 3.7.4.3.

For **Peak Sampling** mode, the slow filter output is instead sampled a fixed time after the X-ray is detected.

Perform the following steps:

- 1. Select the desired peak capture method.
- 2. Click [OK].
- 3. In the PARSET area of the Acquisition tab, click [Save] to save the modification to the PARSET.

3.7.4.3 Pileup Inspection: FASTLEN, FASTGAP, MAXWIDTH, PEAKINT

Undetected pulse-pileup results in unwanted pileup peaks in the spectrum. Pileup peaks in the spectrum can often be identified by noting that the apparent energy of the pileup peak is the sum of the energies of the piled-up X-ray pulses.

Two pileup inspection methods are utilized in the VICO-DP:

- Fast pileup inspection monitors the pulse width of the fast filter output, or more specifically, the time during which the Trigger threshold is exceeded.
- Slow pileup inspection monitors the time between two successive threshold crossings.

The fast filter is controlled by the parameters FASTLEN and FASTGAP. It is not necessary to set the FASTGAP in relation to the preamplifier rise time, in fact it is set to zero (0) by default, and should left so in nearly all cases.

For the limiting case of a preamplifier rise time equal to zero, the fast filter produces a trapezoid of maximum width:

Max Width \geq (FASTGAP + 2 · FASTLEN) · sampling interval

The parameter MAXWIDTH sets the **Max Width** limit for acceptable events, in units of the sampling interval (i.e. 25 ns for 40 MHz). The fast filter trapezoidal waveform convolutes the preamplifier rise time t_R with FASTLEN and FAST-GAP, and thus MAXWIDTH should be increased accordingly:

MAXWIDTH \geq FASTGAP + 2 · FASTLEN + (t_n/sampling interval)

The slow **Pileup Inspection Interval** is the time between two successive fast filter pulses. PEAKINT sets the minimum separation. By default it is automatically set to:

Pileup Inspection Interval = Peaking Time + Gap Time

Or

PEAKINT = SLOWLEN + SLOWGAP

...and should be left so in nearly all cases. Lower settings will increase the magnitude of pileup peaks.



Higher settings may in some special cases improve pileup rejection, but typically it will have no effect on pileup and will always increase the dead-time-per-event and thus reduce throughput. Click the **Edit Filter Parameters** to open the **Edit Filter Parameters** dialog.

- 1. Edit Max Width as necessary.
- 2. Click [Apply].

In ProSpect, the **Pileup Inspection Interval** is defined as an offset from its default value, per above equation. The default offset is thus zero.

To increase the interval,

- 1. Enter a positive number.
- 2. Click [Apply].
- 3. Start a new run and re-examine the ratio of the identified pileup peak to its associated energy peak.
- 4. After the settings have been optimized, click the [Save] button.

Remember that individual settings are stored and retrieved for each Peaking Time!

3.7.5 Viewing the Run statistics

The run statistics are displayed in the upper right corner of the MCA tab. See figure Fig. 10.

Real Time and **Live Time** are displayed in seconds; **ICR** (input count rate) and **OCR** (output count rate) are displayed in kilo-counts-per-second. The total number of **Events** in the spectrum and the **Dead Time** percentage are also displayed.

3.7.6 Livetime and Deadtime

The displayed **Live Time** is NOT the live time of the energy filter, rather it is a measurement of time that the triggering filter remained under threshold. This measurement, along with the number of times the threshold was crossed, or Fast Peaks, is used to calculate the input count rate.

ICR = Fast Peaks / Live Time

The Live Time of the energy filter is not displayed in software, but can be calculated according to:

Energy filter Live Time = Real Time ⋅ OCR / ICR

The **Dead Time** percentage is displayed in software, calculated as:

Dead Time = 1 - OCR/ICR

3.7.7 Saving a Spectrum

The spectrum export function produces a text file with a descriptive header and a list of values, i.e. the number of counts recorded in each MCA bin. The energy-per-bin and run statistics are included in the header.



To save a spectrum,

- 1. select Save MCA Data... from the File menu.
- 2. After the prompt appears, enter the file name.
- 3. Select a location to save the file.

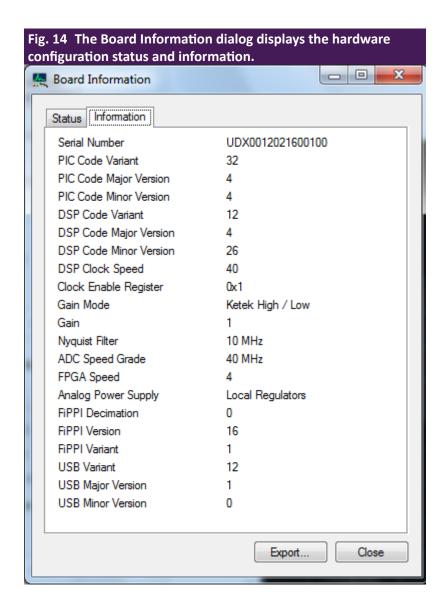
3.8 Diagnostics

3.8.1 Board Status and Information

The **Board Information** dialog is used to display basic information about the configuration and status of the VICO-DP hardware.

- 1. Go to the Tools menu.
- 2. Select Board Information... to open the dialog.
- 3. Click the Status tab to display the current status of the PIC microcontroller and DSP.

If no error conditions have been detected all values should read zero.





- 4. Click the **Information** tab to display the current hardware and firmware configuration, as displayed in Fig. 14.
- 5. Click the [Export ...] button to store all info, i.e. status, history and configuration information, to a text file.

This text file is useful to KETEK support staff when attempting to diagnose hardware and/or firmware problems.

3.8.2 Log Files

- 1. Go to the Tools menu.
- 2. Select **Diagnostics...**to access the software application log files.

The ProSpect tab displays the contents of ProSpect.log, a log of high-level GUI operations.

The Handel tab displays the contents of ProSpect handel.log, which contains low-level information.

Both files are saved to the default location:

C:\Users\<username>\AppData\Roaming\XIALLC\ProSpect\logs

The log files, and particularly the Handel log file, can be helpful to KETEK support staff when attempting to diagnose hardware and/or firmware problems.

3.8.3 The Scope Tool

The **Scope** tab displays 8,000 points of the selected digital signal vector, to be used as a diagnostic tool during setup and debugging.

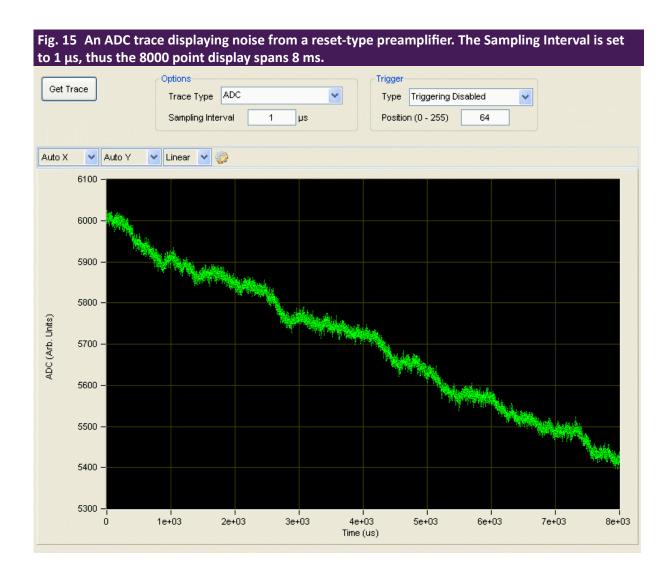
- The **Trace Type** drop-down list selects the source vector.
- The Sampling Interval field controls the time interval between individual points. The minimum value is the ADC sampling interval, e.g. at 40 MSPS the minimum value is 25 ns, and results in a displayed period of 200 μs.
- The **Trigger Type** drop-down list selects the scope trigger source (which is independent of the event trigger for data acquisition mode). We recommend setting **Trigger Type** to **Fast Trigger** in nearly all cases.
- The Position field determines the horizontal position of the triggered event. Its value ranges from 0 to 255, with 128 putting the triggered event at the center of the displayed trace.

In order to make sense of the **Scope** data, it's important to distinguish X-ray pulses from noise, and for reset-type preamplifiers we must also identify preamplifier resets and VICO-DP tracking steps in the display.



3.8.3.1 Identifying Noise

Fig. 16 shows an ADC trace displaying only noise. In this case a significant low-frequency noise component (i.e. in the 100Hz – 1kHz range) is displayed, in addition to high-frequency noise.



High and low-frequency noise are distinguished relative to the spectrometer filter length (i.e. slow filter peaking time): noise components with a period much longer than the peaking time are referred to as low-frequency, and are filtered out through baseline averaging; those with a period much shorter are referred to as high-frequency, and are filtered out through integration in the energy filter itself.

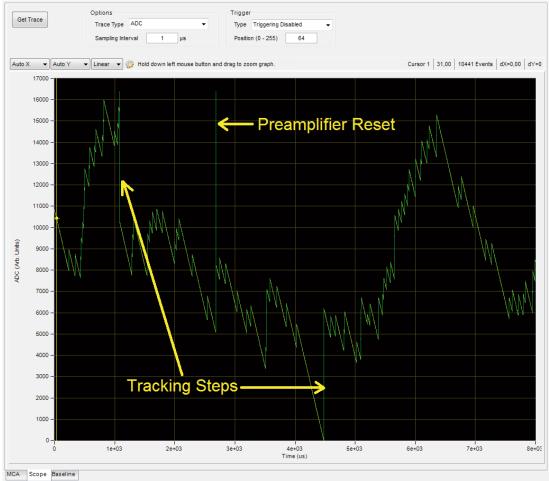
3.8.3.2 Preamplifier Resets and Tracking Steps

Additional signal transients are present for pulsed-reset preamplifiers, and they will often be visible in the ADC and other trace types.

Reset-preamplifiers produce a large corrective reset step when the large-signal 'staircase' waveform reaches its limit. This reset transient varies for different preamplifiers, both in the duration and in other signal characteristics, e.g. rise time, charge-injection, overshoot and settling time.



Fig. 16 There are approximately 120 X-rays displayed for a reset-type detector. The preamplifier reset briefly sends the ADC out-of-range high. The three tracking steps are introduced by the VICO-DP analog signal conditioner (ASC) in response to the signal first drifting out-of-range low twice, then out-of-range high once.



Other transients, called tracking steps, are due to the VICO-DP itself. The analog signal conditioner (ASC) dynamically maintains the signal within the ADC input range by introducing large voltage steps of approximately one half the ADC range (i.e. pushing the signal from the ADC boundary to near mid-range).

The resulting transient tracking steps are qualitatively similar to the step produced by an X-ray, but occur with both rising and falling edges.



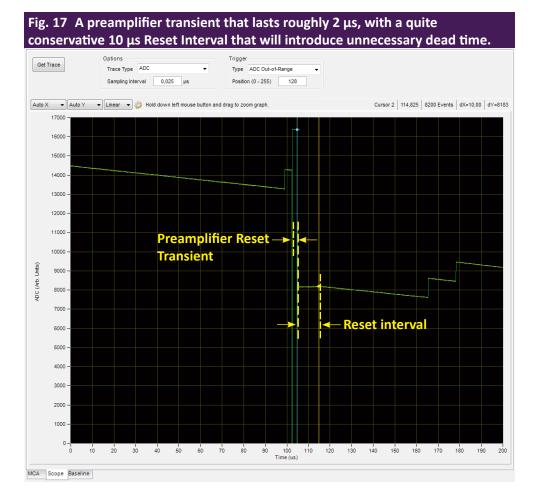
NOTE

The individual X-ray steps are in the range 1000 vertical units, which is approximately 6% of the ADC input range. We frequently refer to X-ray step heights in terms of ADC percentages.

Tracking steps can be identified by noting that the transients originate near the ADC minimum (0) or maximum (16384) and terminate near mid-range (6000 to 10000).

One preamplifier reset and three tracking steps are displayed in Fig. 17.





3.8.3.3 The Preamplifier Reset Interval

The **Reset Interval**, expressed in units of microseconds (μ s), determines the wait time after the preamplifier reset transient during which the spectrometer is disabled.

A proper setting ensures that the reset transient doesn't pollute the baseline or spectrum, and that excessive dead time is not incurred.

- 1. In the **Scope** tab, select **ADC** from the **Trace Type** drop-down list.
- 2. Set the **Sampling Interval** to the minimum value, i.e. enter "0".
- 3. Select ADC Out-of-Range for the Trigger Type and
- 4. Enter 128 in the Position field.
- 5. Click the [Get Trace] button to acquire data.

We are triggering on the ADC going out of range, thus we should see either a tracking step or a preamplifier reset at the center of the plot. The tracking steps can be identified as starting at roughly 0 or 16384, and quickly terminating near the center of the ADC range.

Preamplifier reset transients look different: they start anywhere in the ADC range and they often go out of range high and low, and/or stay out of range for a while.

If you're having trouble identifying preamplifier resets, try setting the **Reset Interval** to a value larger than the default 5 µs, so that the resulting flat area after the transient can clearly be observed as in Fig. 17.

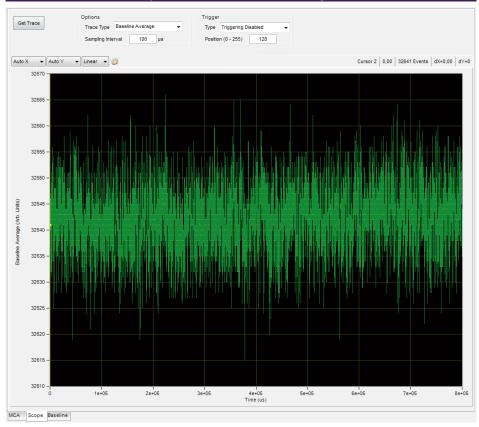
The idea is to set the **Reset Interval** such that the ADC signal goes flat for a finite but brief period of time, e.g. $2 \mu s$, after the preamplifier transient.



The **Reset Interval** setting can be modified in the **Detector** tab:

- 1. Enter the Reset Interval in microseconds.
- 2. Click the [Apply / Save] button.

Fig. 18 A good Baseline Average trace. Note that the zero point has been shifted to 32768 in the plot area because this is a signed vector.



- 3. As a final check, select **Baseline Average** from the **Trace Type** drop-down list.
- 4. Acquire a trace at 100 μs **Sampling Interval**.

The ideal trace should look like white noise, as in Fig. 18. Significant transients and/or periodic signals warrant a more conservative Reset Interval setting.



NOTE

All of the Trace Type signals except for ADC and ADC Average are signed 2's complement vectors.

3.8.4 Baseline Acquisition

Proper baseline acquisition and averaging is critical to the VICO-DP's performance. The baseline is the output response of a digital filter when no photons are present. As is standard in pulse-processing applications, baseline measurements are averaged over a time interval value that is sufficiently long to eliminate high-frequency noise, but short enough that the average tracks actual variations in the preamplifier output independent of incident photons. This average is subtracted from the instantaneous measurements of step-pulse heights, yielding improved threshold stability with count rate and the improvement in noise associated with the double-correlated pulse-height measurement.



Tab. 4 Trace Type Definition			
Trace Type	TRACETYPE	Description	
ADC	0	The raw ADC samples (with optional inversion according to the Polarity setting)	
ADC Average	1	A running average of the ADC samples, where the average length is equal to the Baseline Average Length	
Fast Filter	2	The fast trigger filter output after fast baseline subtraction, scaled to the same units as the Trigger Threshold	
Raw Intermediate Filter	3	The output of the intermediate baseline filter, before baseline subtraction	
Baseline Samples	4	Samples of the raw intermediate filter when at baseline	
Baseline Average	5	A running average of the Baseline Samples, where the average length is equal to the Baseline Average Length, that is subtracted from both the intermediate and energy filters	
Scaled Intermediate Filter	6	The intermediate baseline filter after baseline subtraction and scaling by the digital gain coefficient	
Raw Energy Filter	7	The output of the slow energy filter, before baseline subtraction	
Scaled Energy Filter	8	The slow energy filter after baseline subtraction and scaling by the digital gain coefficient	

Baseline acquisition is controlled by the Baseline Threshold, the number of samples averaged, or Baseline Average Length, and the Reset Interval, the time interval after each preamplifier reset during which data acquisition is disabled.

The baseline is displayed in two ways: a histogram of baseline samples, i.e. the distribution of instantaneous baseline measurements, is displayed in the Baseline tab. With proper settings, the baseline histogram is an accurate representation of system noise.

The **Baseline Average** in the **Scope** tab displays the computed average as a function of time.

Theoretically the distribution of baseline samples is Gaussian with a constant average value.

Real world detectors and preamplifiers generate several types of nonlinearities in the baseline distribution, and the mean value may wander with temperature, the rate of incident photons, etc.

These effects can be addressed by reducing the number of samples in the average, or the Baseline Average Length, as described in § 3.8.4.2, or perhaps by increasing the detector **Reset Interval** setting, as described in § 3.8.3.3.



⚠ NOTE

The default setting, i.e. conservative Trigger Threshold setting with other thresholds disabled, provides little discrimination against low-energy X-ray events, thus the baseline histogram may include the soft X-ray regime of the spectrum as well as the noise peak, as in Fig. 19. Nonetheless at low to moderate event rates the vast majority of the measurements still fall on the noise peak as intended, and the baseline average is still largely functional. At higher rates the average will be increasingly corrupted by the growing energy component in the average, resulting in a rate-dependent shift in measured event pulse-heights. This degradation disappears when the baseline threshold is set correctly.



Fig. 19 Baseline histogram acquired with very conservative threshold settings. The vertical axis is displayed on a logarithmic scale. Note the noise peak at zero, and the significant energy soft X-ray component to the right.

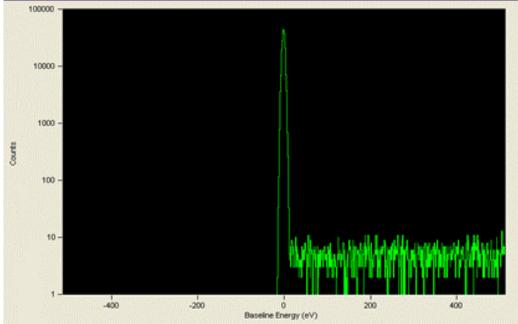


Fig. 20 A very clean baseline histogram with thresholds set correctly—the noise peak is isolated and Gaussian in appearance.

3.8.4.1 The Baseline Threshold

The **Baseline Threshold**, which has a 12-bit range, is used both to acquire valid baseline samples and to trigger on X-ray events in the intermediate filter. An aggressive setting can result in better sensitivity to low-energy X-rays.

An overly-aggressive setting can interfere with baseline sampling and introduce a noise peak in the spectrum.



The **Baseline Threshold** is disabled by default (thresholds can be disabled by setting them to 0). See § 3.7.1.1 for instructions on setting the **Baseline Threshold**.

Follow this procedure:

- 1. Open the Baseline tab.
- 2. Click [Get Baseline] to refresh the histogram display.

If the Baseline Threshold is set too high, part of the energy spectrum may be displayed in the baseline distribution as in Fig. 19. If the Baseline Threshold is set correctly, only the noise peak should be visible. For a high quality detector and preamplifier, the noise peak should resemble a symmetric Gaussian distribution as shown in Fig. 20.

3.8.4.2 Number of Samples in the Baseline Average

Real-world detectors and preamplifiers can produce a baseline that varies over time or voltage. A time-variant, or wandering, baseline can be mitigated by reducing the number of samples averaged, or **Baseline Average Length**. It is part of the PARSET, and thus stored on a per-peaking-time basis. Reducing the number of samples allows the average to track with the real variations in the baseline, and thus yields better accuracy. Conversely, fewer samples in the average results in less noise reduction, and thus less precision in the pulse-height measurement.

- 1. In the **Scope** tab, select **Baseline Average** from the drop-down list.
- 2. Click the [Get Trace] button.

A large Sampling Interval, e.g. 10-100 μs, is best, because the baseline itself is only sampled periodically.

Each point in the display represents the averaged baseline at that instant. The number of baseline points included in the average is determined by the DSP parameter BLFILTER according to the following equation:

Baseline Average Length =
$$\frac{32768}{BLFILTER}$$

BLFILTER defaults to 64 or 128, thus the default **Baseline Average Length** is 512 or 256. We have found this to be a good balance for most detectors over a range of peaking times. At very high rates, and alternatively for lower quality detectors with significant real variations in the baseline, it is best to reduce the **Baseline Average Length**.

At shorter peaking times it is often advantageous to average more points because each individual point contains a larger noise component than for longer peaking times.

- Open the Acquisition tab.
- 2. Select the desired Baseline Average Length from the drop-down list and click [Apply].
- 3. Click [Get Trace] in the **Baseline** tab to refresh the display.
- 4. Repeat steps 1 3 as necessary.
- 5. When the desired performance has been verified, click [Save].

Remember that individual settings are stored and retrieved for each Peaking Time.



4 Contact

If you have any questions regarding this or any of our products please do not hesitate to contact us via e-mail or phone.

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